

**DISPLACEMENT SENSOR AND METHOD FOR
PRODUCING TARGET FEATURE THEREOF**

5 Related Application

This application is a continuation-in-part of U.S. Serial No. 08/573,170, filed on December 15, 1995, entitled "Non-Contact Position Sensor".

Field of the Invention

The present invention relates generally to an optical apparatus for accurately measuring minute
10 displacements of a movable object and, more particularly, to a method for forming a target feature employed in the optical apparatus.

Background of the Invention

There is a great need in many applications to monitor the positions of a movable object relative to a desired position or positions. For example, it is desirable in disk drive servo systems to
15 accurately detect the positions of a rotatable read/write head arm, relative to desired, known positions, so that the head arm can be moved into alignment with desired radial track locations on a disk to enable the read/write head to read from and write to such locations. Position sensing devices are devices aimed at providing such position detection. Displacement sensors are position sensing devices that monitor the positions of a movable object by repeatedly measuring the displacements of
20 the object from a desired location.

Examples of conventional displacement sensors include capacitance gage devices, fiber-optic proximity sensors and optical sensors, such as interferometric sensors used commonly in disk drive servo systems. Many of the prior art displacement sensors either are incapable of achieving the degree of resolution (the smallest measurable displacement) required by certain applications (such
25 as disk drive servo systems) or require expensive and/or complex circuitry and hardware to achieve such resolution. To achieve high resolution, certain displacement sensors require, for example, a precise and powerful laser light source or extremely close proximity between the sensing element and movable object, rendering such devices expensive and difficult to implement. Thus, a balance must be struck between device performance and simplicity.

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U.S. Patent No. 5,315,372 to Tsai describes a prior art disk drive servo system that employs an optical displacement sensor. The Tsai device includes a light source and a photodetector array attached, at spaced-apart locations, to a rotatable master arm, located externally of the disk drive. A reflector is attached to a rotatable read/write head arm at a location between the read/write head and the axis of rotation of the arm. During operation, the master arm first is aligned accurately with a desired radial track location on the disk using an interferometric device. Then, the displacement sensor operates to determine the position of the head arm relative to the master arm so that the head arm can be moved into alignment with the master arm.

The light source of the displacement sensor produces an incident light beam that is reflected by the reflector onto the photodetector array. The position on the photodetector array to which the light beam is reflected depends on the relative radial positions of the head and master arms. Each photodetector element of the array produces an electric signal having an amplitude proportional to the intensity of the received light. The signals produced by the array, thus, represent the relative radial positions of the head and master arms. Processing circuitry receives and decodes the signals output by the array to determine the relative head arm position and accordingly controls a motor to rotate the head arm until it is properly aligned.

The device disclosed in the Tsai patent suffers from a number of drawbacks. While the Tsai device is relatively structurally simple and fairly inexpensive to implement, it is burdensome to operate. The Tsai device requires a pre-knowledge of each master arm and relative head arm position in order to accurately interpret the electric signals produced by the photodetector array. Also, due to the significant spacing between the reflector and the read/write head on the head arm and, due also to the dual axes of rotation of the head arm and master arm, performance accuracy is sacrificed severely. Further, the displacement sensor of Tsai aims to monitor radial movements (those caused by rotations about the axis) of the head arm relative to the master arm. Because the reflector reflects the incident beam directly onto the photodetector, spaced significantly from the reflector, the sensor is sensitive not only to radial movements of the head arm but also to angular movements of the reflector. Thus, the precise angular orientation of the reflector on the head arm is crucial to precise operation. Any angular movements of the reflector with respect to the head arm may cause false measurements to occur.

A general object of the present invention to provide a method for forming a target feature employed within a simple, yet accurate, optical displacement sensor.

Summary of the Invention

One embodiment of the invention is directed to a device for measuring the displacement of a
5 moveable object. In the device, a stationary light source produces an incident light beam. A target
feature, attached to the object, reflects the incident light beam and forms a first image of the light
source in close proximity of the target feature. An imaging lens receives the first image and reforms
the first image as a second image of the light source on a photodetector. The photodetector, spaced
from the object, receives the second image and, in response thereto, produces an electric signal
10 having a characteristic which is proportional to a received location on the photodetector of the
second image and which represents a position of the object. The target feature is formed by ruling a
groove within the object.

In one embodiment, the target feature groove is semi-cylindrical in shape.

In one embodiment, the target feature has a radius of curvature within the range of .2-5.0 mm.

15 Another embodiment of the invention is directed to an optical position sensing device for
sensing a position of a read/write head arm relative to that of a master arm in a disk drive. The
device includes a light source, attached to the master arm, that produces an incident light beam. A
target feature, attached to the head arm, reflects the incident light beam and forms a first image of a
light source in close proximity of the target feature. An imaging lens located in a light path between
20 the target feature and photodetector, receives the reflected light beam and refocuses the first image
of the light source as a second image on the photodetector. The photodetector, attached to the
master arm, receives the second image and, in response thereto, produces an electric signal having a
characteristic which is proportional to a received location on the photodetector of the second image
and which represents a relative position of the head arm. The target feature is formed by ruling a
25 groove within the object.

Another embodiment of the invention is directed to a method of forming a target feature within
an object, a displacement of the object to be sensed by a displacement sensor, the displacement
sensor including a light source that produces an incident light beam that reflects from the target
feature and a photodetector that receives an image of the light source produced by the target feature.

The method comprises the steps of: bringing a ruling surface of a ruling tool into contact with a surface of the object; and while maintaining pressure on the ruling tool against the surface of the object, ruling the target feature into the surface of the object.

In one embodiment, the step of ruling includes the step of retaining the object stationary.

5 In another embodiment, the step of ruling includes the step of retaining the tool stationary.

The features and advantages of the present invention will be more readily understood and apparent from the following detailed description of the invention, which should be read in conjunction with the accompanying drawings, and from the claims which are appended to the end of the detailed description.

10 **Brief Description of the Drawings**

Fig. 1 is a block diagram of a general embodiment of a displacement sensor employing a target feature formed according to the invention;

Fig. 2 is a more detailed diagram of a specific embodiment of the displacement sensor;

Fig. 3 is a graph illustrating an electric signal produced from the outputs of a bi-cell
15 photodetector of the sensor;

Fig. 4 is a detailed block diagram of a disk drive servo system also employing a target feature formed according to the invention;

Fig. 5 is a part structural, part functional block diagram illustrating operation of the disk drive servo system;

20 Figs. 6A and 6B are electrical block diagrams of the processing circuitry of the disk drive servo system;

Fig. 7 is a detailed diagram of one embodiment of the target feature employed in the disk drive servo system;

Fig. 8 is a diagram of the side view of the target feature and head arm tip shown in Fig. 7;

25 Fig. 9 is a more detailed diagram of the portion of an embodiment of the displacement sensor of the present application;

Fig. 10 is a diagram of one embodiment of a tool that can be used to rule the target feature according to the invention;

Fig. 11 is a part structural, part functional diagram illustrating the ruling of the target feature according to an embodiment of the invention;

Fig. 12 is a part structural, part functional diagram also illustrating the ruling of the target feature according to an embodiment of the invention;

5 Fig. 13 is a diagram illustrating a particular tool with which the target feature can be ruled according to an embodiment of the invention; and

Fig. 14 is a more detailed diagram of the ruling surface of the tool of Fig. 13.

Detailed Description

Fig. 1 is a general block diagram of one embodiment of a displacement sensor employing a
10 target feature formed according to the invention. As shown, the sensor includes a stationary light source 10, a movable object 14, a stationary imaging lens 26 and a stationary photodetector 20. A target feature 16 is attached to, or integral with, movable object 14. Object 14 is movable in the direction shown by arrow X and the displacement sensor monitors the position of object 14 by measuring displacements of object 14 from a reference position.

15 Light source 10 produces an incident light beam 12 which is reflected by target feature 16 as a reflected light beam 18. A first point-like or line-line image (not shown) of the source 10 is formed in close proximity of target feature 18 due to a small curved reflective surface thereon. The first image moves with movement of the target feature. Light beam 18 is focussed by lens 26 such that a second image 19 (like the first image) of the light source is formed on a surface of photodetector 20.

20 Photodetector 20, in response to receipt of the reflected light beam 18 (and second image), produces an electric signal having a characteristic (such as amplitude or frequency) that is proportional to the position on the surface of photodetector 20 at which the reflected light beam is received (i.e., where the second image is formed) and, therefore, also corresponds to the present position of the object 14. Processing circuitry (a particular embodiment of which is described below with reference to Fig.

25 6B) can be connected to the photodetector to receive the electric signals produced by the photodetector and process such signals to determine the position of the object and/or displacement of the object from a known reference position. The circuitry can include both analog and digital signal processing circuitry.

As described in greater detail with reference to Fig. 9, target feature 16 includes a curved surface 17 which reflects incident light beam 12 such that a first small, preferably point-like or line-like, image of source 10 is formed in close proximity of the target feature and is reformed by lens 26 as a second image onto the surface of photodetector 20. Photodetector 20 is increasingly sensitive to smaller displacements as the size of the image is decreased. It, therefore, is desirable to refocus a small, point-like or line-like, image of the source onto the photodetector surface.

As will be described in greater detail below, curved surface 17 of target feature 16 can be concave or convex. Target feature 16 can be formed integral with object 14 as described below with reference to Figs. 10-13. For example, target feature 16 can include a curved surface that is formed within a portion of object 14. Alternatively, target feature 16 can be a separate element that is affixed to object 14. For example, the target feature 16 can be a cylindrical element such as a pin that is welded, brazed, soldered, screwed or otherwise affixed to object 14. Curved surface 17 of target feature 16, if attached as a separate element, should be sufficiently smooth and preferably polished so that the incident light beam is efficiently reflected.

Referring to Fig. 1, as object 14 is moved in the direction of the arrow X, the position on the surface of photodetector 20 where reflected beam 18 is received moves in the opposite direction, shown by arrow X'. Photodetector 20, in response, produces electric signals wherein each signal has a characteristic (i.e., amplitude or frequency) that is proportional to the position on the photodetector surface of reflected beam 18 and, thus, also to the relative position of object 14.

The displacement resolution of the sensor increases as the size of the image of the light source reflected onto the photodetector surface decreases. Additionally, the displacement resolution of the sensor increases as the intensity of the incident light beam increases. Because the use of a target feature having a curved surface greatly reduces the size of the light source image (i.e., to a point-like or line-like image) reflected onto the photodetector surface, the requirement for a highly efficient and expensive laser light source is greatly relaxed in order to achieve a high degree of displacement resolution.

Fig. 2 is a more detailed diagram showing a particular embodiment of the displacement sensor of the present invention. Like elements in Fig. 2 are referred to by identical reference characters to those in Fig. 1. As shown, the sensor includes laser diode light source 22, object 14, to which target

feature 16 is attached, or with which target feature 16 is formed integral, and bi-cell photodetector 28. Also included are a gradient index (GRIN) incident laser diode beam collimating lens 24 and reflected beam focussing lens 26.

Laser diode 22 conventionally produces incident laser beam 12 (shown in Fig. 2 as two
5 separate laser beams) which is provided through GRIN collimating lens 24 to target feature 16. Each of laser diode 22, GRIN collimating lens 24 and bi-cell photodetector 28 can be conventional elements. Incident laser beams 12 reflect from curved surface 17 of target feature 16 to form a first small point-like or line-like image (not shown) of the source in close proximity to the target feature and reflects incident beams 12 as reflected beams 18. The small, point-like or line-like first image
10 is reformed by lens 26 as a second image 30 on upper surface 31 of bi-cell photodetector 28. Lens 26 receives beams 18 and focusses the second image 30 onto photodetector 28. Curved surface 17 of target feature 16 enables a small, point-like or line-like image 30 of the light source 22 to be refocussed on surface 31 of photodetector 28.

As explained in greater detail below, with a cylindrical target feature formed within the object,
15 the first image is formed at the intersection or convergence of the light beams reflected from the target feature. By contrast, with a cylindrical target feature attached to and extending outwardly from a surface of the object, the first image actually is a virtual image at a point within the target feature from where the reflected beams appear to emanate.

Because a first point-like image is formed in close proximity of the target feature, the system is
20 significantly insensitive to movements of the object and target feature (such as radial movements) not sought to be measured. For example, if object 14 rotates slightly about an axis formed in the Y direction (parallel to the longitudinal axis of the target feature), the measurement will not be affected. This is so because the portion of reflected beams 18 (and first image) on the surface of lens 16 will change but the position of second image 30 on photodetector 31 will not change. Thus,
25 the system of the invention is insensitive to small radial movements of the object.

Bi-cell detector 28 includes two photodetector cells A and B separated by narrow strip 32. As object 14 moves in direction X, point image 30 moves across surface 31 of bi-cell detector 28 in the opposite direction X' from cell A to cell B. The center of point image 30 is shown in Fig. 2 as being located on strip 32 between cells A and B. The sensor could be calibrated to have a null or

reference position (a position in which object 14 is at a desired location) when the center of point image 30 is focussed on strip 32 between cells A and B.

Each cell A or B of bi-cell photodetector 28 produces an analog electric signal having an amplitude that depends upon the location of the point image 30 on the cell surface. Each cell produces the strongest electric signal when the point image 30 is located wholly upon the surface of that cell. By monitoring the ratio of $(A-B)/(A+B)$, where A and B respectively denote the amplitudes of the electric signals produced by cells A and B of detector 28, the position of point image 30 on the surface of photodetector 28 can be monitored and, thereby, the position of object 14 (relative to the stationary light source and photodetector) also can be monitored. This is so because the position of the point image 30 on the surface of photodetector 28 may be related linearly to the relative position of object 14. The ratio of $(A-B)/(A+B)$ can be monitored with the use of processing circuitry (see Fig. 6B) that would be electrically connected to the outputs of bi-cell detector 28. Such circuitry could include digital signal processing circuitry that could be connected to a computer having a display such that a user could easily visually monitor the position of object 14.

The sensor is insensitive to movements in the Y, Y', Z or angular (about the Y axis) directions. In order to reduce the sensitivity of the sensor to vertical movements (away from or toward the laser diode and photodetector) of the object, the plane formed by the incident laser beam 12 and reflected laser beam 18 is substantially orthogonal to an axis formed between the center points of cell A and cell B and is substantially parallel to strip 32. Thus, for example, if the object 14 moves from a first position, such as the one shown in Fig. 2, vertically (away from the laser diode and photodetector) in the direction of arrow Z to a second position, then the point image 30 would move in the direction of arrow Y' on the surface of photodetector 28, perpendicular to direction X and would not effect the electric output signals of the photodetector.

As shown in Fig. 2, target feature 16 may have a longitudinal axis that is parallel to the plane (shown in dotted lines) formed by incident laser beam 12 and reflected laser beam 18 and is parallel to strip 32 of photodetector 28 and perpendicular to an axis formed through the center point of each cell of the bi-cell detector so that the sensor will be insensitive to minor lateral movements (in the Y direction or in the Y' direction).

The arrangement described advantageously provides insensitivity to movements of the object in the Z (upward), Y or Y' (lateral in plane formed by incident and reflected light beams), and radial (about axis formed in Y direction) directions. Only movements of the object in the X (perpendicular to plane formed by incident and reflected beams) direction will be measured.

5 Fig. 3 is a graph showing the difference (A-B) of the amplitudes of signals A and B versus time as object 14 is moved in the direction of arrow X (shown in Fig. 2). In this example, it is assumed that object 14 is in a position at time zero such that the point image 30 is focussed off of surface 31 of bi-cell photodetector 28 (before reaching the surface of cell A). As object 14 moves in direction X, point image 30 first reaches surface 31 of cell A and then continues across strip 32 to
10 cell B.

When the leading edge of point image (which is finite in size and appreciably larger than the width of the gap between A and B) 30 reaches the edge of cell A (after time 1), signal (A-B) begins to increase from zero, reaching its maximum value when the image is wholly on cell A (at time 2). When the leading edge of the image reaches the gap between cells A and B (at time 3), the signal
15 (A-B) begins to decrease, passing through zero when the point image is centered on the gap between cells A and B, and lies equally on cells A and B. As the point image continues on to cell B, the signal (A-B) continues to decrease, reaching its minimum value when the image lies wholly on cell B (time 4). When the point image moves off of cell B (time 5), the signal (A-B) increases back to zero. The slope of the curve (A-B) versus image position is at a maximum when the image lies on
20 both A and B, and increases in value as the size of the point image is reduced, while still remaining larger than the width of the gap between cells A and B.

Thus, it can be seen that by observing signal A-B, the position of point image 30 on surface 31 of bi-cell photodetector 28, and thus the linearly related relative position of object 14, can be monitored. Similarly, a displacement between a first position and a second position of object 14 can
25 be measured.

The dynamic range (the range of positions of the object within which accurate measurements can be made) of the sensor falls within the linear range of the A-B signal curve and is shown on the graph of Fig. 3 between dotted lines labeled DR (approximately between times 2.5 and 3.5). Additionally, the system has a minimum capture range which is a minimum accurately detectable

level of signal $A-B$. This capture range is illustrated between dotted lines labeled CR. The slope of the $A-B$ signal curve in the linear dynamic range (in milliamps/micron) corresponds to the responsivity (or sensitivity) of the bi-cell detector. As the slope of the curve in this region increases, the resolution (the minimum detectable displacement of the object) achievable of the sensor
5 increases but the dynamic range of the sensor decreases. Thus, it should be appreciated that with the sensor described, a balance must be struck between the dynamic range and displacement resolution.

The amplitude of signal $A+B$ (when point image 30 is focussed on surface 31 of bi-cell detector 28) can be maintained approximately constant so that monitoring the ratio of $(A-B)/(A+B)$ can be more simply accomplished only by monitoring signal $A-B$. Maintaining signal $A+B$
10 constant can be accomplished by controlling the intensity of input laser beam 12 using automatic gain control (AGC) circuitry (one embodiment of which is described below with reference to Fig. 6A) electrically coupled to the laser diode 22. As described below, the AGC circuitry monitors signal $A+B$ while controlling the power provided to the laser diode. Thus, in order to more simplify the processing circuitry necessary for monitoring the output electrical signals produced by bi-cell
15 detector 28, an AGC circuit can be employed.

The light source 10 can be any type of light source that produces an incident light beam having sufficient intensity to be detected by the photodetector to meet the sensitivity requirements of a particular application. The light source can, for examples, include a laser diode, a light emitting diode (LED), an LED, a tungsten light source, or an optical fiber light source. If an optical fiber
20 light source is employed, then a pair of optical fibers, or a bifurcated fiber, would be employed to direct the reflected laser beams to the photodetector. In one embodiment, the power of the light source preferably falls within the range of .1 milliwatt - 20 milliwatt. Also, the strength of the incident laser beam preferably is approximately equal to 1 mwatt/100 μ .

Various types of focussing optical elements can be employed to direct the incident and
25 reflected light or laser beams. For example, conventional lenses, spherical or cylindrical mirrors, GRIN lenses, or molded aspheric lenses can be employed.

The photodetector can be any type of optical photodetector which produces an electric signal having a characteristic (such as amplitude or frequency, for examples) that is proportional to the position on the surface of the detector of the received light beam. The photodetector can, for

example, be a position sensor in which the amplitude of the electric signal produced is directly proportional to the location on the sensor where the reflected beam is received. The photodetector preferably includes a spatially arranged photodetector capable of generating a signal or signals from which a ratio (such as $(A-B)/(A+B)$) can be generated. For example, the photodetector can be a bi-cell detector, a quad-cell detector, a CCD array or other.

An advantage of the sensor described is that by monitoring the ratio of $(A-B)/(A+B)$, the sensor is somewhat insensitive to the strength of the light source, the reflectivity of the target feature and the sensitivity of the photodetector.

In one embodiment, each cell of the bi-cell detector has dimensions of .6 mm by 1.2 mm and the gap between the cells (the width of strip 32) is approximately equal to $10\text{ }\mu\text{m}$. The width of image 30 can fall within the range of $50\text{ }\mu\text{m}$ - $100\text{ }\mu\text{m}$. A standard sensitivity for such photodetector is approximately equal to .4 amps/watt.

In a typical application, such as a servo system application (as will be described hereinafter), lens 26 may be located approximately equidistant between target feature 16 and photodetector 28, approximately 20 mm from each. Reflected beam lens 26 conventionally has a 10 mm focal length. The radius of curvature of curved surface 17 of the target feature 16 preferably falls within the range of .5-5.0 mm in one embodiment.

Fig. 4 is a diagram showing another embodiment in which the optical displacement sensor is used in a disk drive servo system. As shown, the servo system conventionally includes rotatable master arm 40 (located externally of the disk drive [not shown]) and read/write head arm 42 (located within the disk drive). Both master arm 40 and head arm 42 rotate about common axis 44. Attached to the upper surface of end 54 of head arm 42 through a flexure (not shown) is a read/write head (not shown). A target feature is formed integral with the head arm according to the invention. The disk (also not shown), to which data is written and from which data is read, is located above the head arm.

As is conventional in disk drive servo systems, the master arm first is rotated to a reference position in alignment with a radial track location to be written to or read from. Then, through use of the optical displacement sensor system of the present invention, the head arm is rotated to be in alignment with the master arm so that the read/write head can read from or write to the desired

radial track location of the disk. The head arm and master arm also can be rotated in other orders including, for example, in alternating fashion until precise alignment is achieved.

The master arm first is aligned using an interferometric optical system. The interferometric system includes a laser source 46, a fold mirror 48, a laser interferometer 50, a retroreflector 52, 5 attached to the underside of master arm 40, and an interferometer output signal detector 61 (shown in Fig. 5). Master arm VCM drive circuitry 63 is coupled between interferometer output signal detector 61 and voice coil motor (VCM) 65, which controls the rotational movement of master arm 40.

As should be understood, a laser interferometer employs a first laser beam, which reflects off 10 of a moving target (i.e., retroreflector 52), and a reference laser beam, which travels a fixed distance, to determine the position (or displacement) of the moving target. The laser source 46 produces a laser beam which reflects from fold mirror 48 through laser interferometer 50 to retroreflector 52. The beam is reflected by retroreflector 52 and is combined with a reference beam by interferometer 50. Interferometer 50 provides the combined beams to detector 61 which, in response, determines 15 the displacement (or change in position) of master arm 40. Then, detector 61 sends a signal indicative of the position change to drive circuitry 63 which, in turn, provides a signal to VCM 65 to rotate master arm 40 until it is aligned with the selected radial track location.

Once the master arm 40 is properly aligned, head arm 42 then is aligned with master arm 40 using the displacement sensor described. The sensor includes source module 56 (preferably 20 including a laser diode), reflector 58 and detector module 60 (preferably including a bi-cell photodetector), all attached to an upper surface of master arm 40. Like the general embodiment of the displacement sensor described above with reference to Figs. 1 and 2, during operation, the laser diode within source module 56 produces an incident laser beam which is reflected by reflector 58 to a target feature (not shown) integral with, or attached to, the underside of end 54 of head arm 42. 25 As described above, the target feature has a curved surface from which the incident laser beam is reflected to form an image of the source in close proximity of the target feature. The reflected laser beam then is reflected from reflector 58 to detector module 60. The image is refocussed on photodetector within module 60.

The system is calibrated such that when head arm 42 is properly aligned with master arm 40, a small, point-like or line-like image 30 (see Fig. 2) is focussed on the surface of dividing strip 32 between cells A and B of the bi-cell detector within detector module 60. Displacement sensor processing control circuitry 67 (shown in Fig. 5) is electrically connected to source module 56 and detector module 60 (Fig. 4) and, as will be described in more detail below, includes circuitry for determining and monitoring the values of signals $A+B$ and $A-B$, which signals represent the relative positions of the head and master arms. Head arm VCM drive circuitry 69 is coupled between displacement sensor processing control circuitry 67 and head arm VCM 71. Displacement sensor processing control circuitry 67 provides a digital output signal indicative of the relative head arm and master arm positions to head arm VCM drive circuitry 69 which, in response, provides a control signal to VCM 71 to rotate head arm 42 until it is aligned with master arm 40. As will be described in greater detail below with reference to Fig. 6A, the sensor also includes AGC circuitry, coupled between the photodetector and laser diode, for maintaining constant signal $A+B$.

Fig. 6A shows in block diagram form, the sensor AGC circuitry. The circuitry is shown as including bi-cell detector 62 (included within detector module 60) and laser diode 72 (included within source module 56) for description convenience. The circuitry includes conventional analog signal amplifiers 64 and 66 connected to respectively receive output signals A and B from bi-cell detector 62. Analog amplifiers 64 and 66 respectively amplify analog signals A and B. The amplified analog signals A and B are provided as outputs and also are provided to AGC circuit 73. AGC circuit 73 consists of analog summing circuit 68 and laser control power circuit 70. Summing circuit 68 produces sum signal $A+B$. Signal $A+B$ is provided to laser control power circuit 70 which monitors the magnitude of sum signal $A+B$ and, in turn, provides an output signal to control the power of laser diode 72 signal $A+B$ is maintained substantially constant. It should be appreciated that the intensity of the incident laser beam produced by the laser diode may vary as the reflectance of the target, for example, varies, in order that signal $A+B$ be maintained constant.

Fig. 6B shows, in block diagram form, head arm processing control circuitry 69 which controls head arm VCM 71. As shown, signals A and B are received by block 74 which includes amplifiers and adder and subtractor circuits for producing signals $A-B$ and $A+B$. Signal $A-B$ is provided to an analog-to-digital converter (ADC) 76 which converts analog signal $A-B$ to a digital signal. The

digital signal is provided to a conventional buffer 78 which provides a digital output representing signal A-B.

Signal A+B is provided to comparator 80 which compares signal A+B with a reference signal (a minimum threshold level [i.e., zero]) and provides a status output bit indicative of whether signal A+B is greater than the minimum threshold level. Circuitry 69 controls VCM 71 to rotate head arm 42 until signal A-B is equal to zero and it is determined that such zero crossing point (of signal A-B) corresponds to the point when the image point is focussed on the strip between the cells of the bi-cell detector (indicating that head arm 42 and master arm 44 are in alignment). It should be appreciated (as discussed above with reference to Fig. 3) that signal A-B also may have a value of zero when the point image is not located on the surface of either of the cells of the bi-cell detector (indicating that head arm 42 and master arm 40 are significantly out of alignment). The circuitry determines that the appropriate zero crossing is reached by monitoring signal A+B with comparator 80. With reference to Fig. 3, it should be understood that the appropriate zero crossing point of signal A-B is reached when signal A-B is equal to zero and signal A+B is greater than zero. When comparator 80 determines that signal A+B is greater than zero, a status bit is output. Thus, the digital output signal provided by buffer 78 and status bit provided by comparator 80 together indicate when head arm 42 and master arm 40 are aligned properly.

Fig. 7 shows in more detail, end 54 of head arm 42. The bottom surface of head arm 42 is shown to illustrate target feature 86. A slider flexure 84 is attached to the upper surface of head arm 42 by welding. Spot welds 82 are shown. A slider and read/write head (not shown) are connected to the tip of flexure 84. Such a construction of the flexure, slider and read/write head is conventional.

In one embodiment of the invention, the target feature 86 is formed integral with end 54 of head arm 42. As described in more detail below, the target feature can be "ruled" into end 54 of head arm 42 using a ruling tool that produces a curved surface preferably having a longitudinal axis parallel to the longitudinal axis of head arm. The target feature can, for example, be a cylindrical indent 88 within the head arm 42, as shown. The cylindrical indent 88 provides the curved surface of the target feature 86 that reflects the incident laser beam. The radius of curvature of the curved surface preferably falls within the range of 0.5-5.0 mm in this embodiment.

Fig. 8 is a side view of end 54 of head arm 42 showing slider 92 attached to flexure 84. As shown, slider 92 is located beneath target feature 86 at approximately the same longitudinal point along the head arm 42. Also shown is a shoulder 90 which elevates target feature 86 slightly above the remainder of head arm 42.

5 Fig. 9 is a part functional, part structural block diagram of a portion of the system (like Figs. 1 and 2) illustrating the formation of the first and second images of the light source. Only a portion of the system is shown in Fig. 9. The portion shown includes target feature 16, imaging lens 26 and detector 20.

Two positions of target feature 16 are shown in Fig. 9: A first position (in which the target
10 feature is shown in solid lines), and a second position (in which the target feature is shown in phantom). The second position shows the target feature displaced from its first position in the lateral direction X, which displacement is to be measured by the system of the invention.

As shown, incoming beam 12 reflects from curved surface 17 of target feature 16 as reflected
beams 18. A small, point-like first image 100A of the light source is formed in close proximity of
15 target feature 16. As target feature 16 moves from its first position (referred to as position A) to its second position (referred to as position B), the first point-like image also moves with target feature 16 from its first position (denoted as 100A) to its second position (denoted as 100B).

At each position, a portion of the reflected beams 18 is received by imaging lens 26 and
focused onto a surface of photodetector 20. For position A, a second image 100A' is formed on
20 surface of photodetector 20. For position B, a second image 100B' is formed on surface of
photodetector 20. As can be seen, as target feature 16 moves from position A to position B in
lateral direction X, second point-like image moves from position 100A' to position 100B' (which
corresponds to movement in the X' direction of image 30 on surface 31 of photodetector 20 in Fig.
2). It should be appreciated that second image 100A' (and 100B') corresponds to second image 30
25 in Fig. 2.

In the servo system embodiment (shown in Fig. 4), only rotational movements of the head arm
about axis 44 (which corresponds to movements of object 14 in the X direction in Fig. 2) will be
measured. None of radial movements of the target feature with respect to the head arm
(corresponding to rotation of object 14 about axis Y in Fig. 2), movements of the head arm

vertically away from or toward the master arm (corresponding movements in direction Z in Fig. 2), or movements of the target feature in either direction formed by a longitudinal axis of the head arm (corresponding to movements in direction Y in Fig. 2), will be detected by the system.

The target feature can be formed integral with the object (i.e., E block to which head arms are
5 attached if used in disk drive servo system application) by a process according to the invention. The process includes ruling the target feature into a surface of the object with a tool having a ruling portion.

Fig. 10 shows one embodiment of a ruling tool that can be used for ruling a target feature according to the invention. As shown, the ruling tool 200 includes a handle portion 202 and a ruling
10 portion 204. Handle portion generally is longitudinal and may have any cross sectional shape including rectangular (as shown), square, octagonal, round or other. The ruling portion 204 is attached to a distal end of handle 202 by any suitable means such as being machine-fitted, adhesively attached, or other. Ruling portion 204 may be retained tightly within distal end of handle 202 such that a tight tolerance exists along interface 210 between ruling portion 204 and
15 handle 202.

Ruling portion 204 preferably has a ruling surface 206 at the extreme distal end of ruling portion 204. Ruling surface 206 in one embodiment is round such that a semi-cylindrical target feature will be ruled into a surface of the object. In the embodiment shown, ruling portion 204 has a face 212, preferably flat. Extending rearwardly from face 212 and proximally upwardly (away from
20 the distal end) from surface 206 is a surface 208 of ruling portion 204.

Handle 202 may be made from steel or any other suitable material that has the strength to withstand the ruling process (described below) without bending. The ruling portion, or at least the ruling surface of the ruling portion, should be made from a material that is sufficiently stronger than the material from which the surface of the object is made such that the target feature will be ruled
25 into the surface of the object by the below-described process. In a disk drive servo system application, typically, the E block object to which head arms are attached and into a surface of which the target feature will be formed, is made from aluminum. Preferably, the ruling portion of the ruling tool is made from diamond and the ruling surface portion thereof is polished such that the interface between the ruling surface 206 and the flat face 212 is a sharp line. In such an

application, the ruling portion alternatively could be made from tungsten, sapphire, or other materials capable of ruling a groove into aluminum.

Fig. 11 is a part structural, part functional diagram illustrating the process by which the target feature can be ruled. Shown in Fig. 11 is ruling tool 200 and object 220. Object 220 includes a surface 222 into which the target feature will be ruled. Tool 200 is shown from a side view including handle 202 and ruling portion 204. Flat face 212 faces in a direction in which the target feature will be ruled along a longitudinal axis of the to-be-ruled groove, as will be explained in greater detail below. Because the view of the tool 200 is from the side, Fig. 11 does not show the round nature of ruling surface 206.

10 In the process, surface 206 of ruling tool 200 is brought into contact with surface 222 of object 220. This can be accomplished by moving tool 200 in direction Y1 toward surface 222 and/or by moving object 220 in direction Y2 toward ruling surface 206 of tool 200, preferably while maintaining the longitudinal axis of handle 202 perpendicular to surface 222. When ruling surface 206 is brought into contact with surface 222 of object 220, ruling surface 206 will be at position S. 15 Then, ruling surface 206 is moved further in the direction Y1 in incremental amount Δ . This can be accomplished by moving tool 200 in the direction Y1 and/or by moving object 220 in the direction Y2. At this point, surface 206 will have dug into surface 222 of object 220 and will be at position S- Δ beneath surface 222. In the preferred embodiment of the invention, Δ falls within the range of .02 to .05 mm.

20 The initial movement of ruling surface 206 toward and into contact with surface 222 of object 220 occurs at starting point d which point is the desired beginning point (one of the end points) of the target feature to be ruled. Then, the target feature is ruled by moving tool 200 in direction X1 and/or moving object 220 in direction X2 a distance D to point D+d, which point D+d is the desired end point of the target feature to be ruled. During this step, pressure is maintained on tool 200 in 25 direction Y1 and/or on object 220 in direction Y2 so that surface 206 is maintained at level S+ Δ and the ruled target feature groove will have a depth from surface 222 of Δ . Preferably, the longitudinal axis of handle 202 is maintained perpendicular to surface 222 to ensure symmetry of the resulting groove. The resulting groove will be semi-cylindrical in shape and will have a radius approximately

equal to that of the rounded ruling surface 206. The radius preferably falls within the range of .2-5.0 mm.

When surface 206 reaches end point $d+D$, then either tool 200 is moved in direction Y2 and/or object 200 is moved in direction Y1 until surface 206 is out of contact with surface 222, thus
5 completing the ruling of the groove target feature.

Tool 200 may be retained stationary while moving only object 200. Alternatively, object 220 may be retained stationary. The retention may be accomplished through use of a vise. The process may be accomplished either manually or through aid of a machine such as milling machine in which the object is retained by the stage of the milling machine and the tool is mounted vertically on the
10 milling machine.

Fig. 12 illustrates the semi-cylindrical groove 224 ruled by ruling surface 200 of ruling portion 204 within surface 222 of object 220.

Fig. 13 shows an alternative and preferable ruling tool 300 including a handle 302 and ruling
portion 304.

15 The ruling portion 304 of tool 300 is shown in more detail in Fig. 14 and includes a ruling surface 306, a flat face 312 and a tapered read edge 308. At 310 is the interface between ruling portion 304 and handle 302. One such tool can be obtained under the product name 1135-020 Natural Diamond Tool from the company E. C. Kitzel & Sons, Inc. located in Cleveland, Ohio.

Having thus described at least one illustrative embodiment of the invention, various alterations,
20 modifications and improvements will readily occur to those skilled in the art. For example, while the sensor of the invention was described as one which monitors the position in one dimension (or direction) of an object, by employing a bi-cell detector, it should be appreciated that the invention is not so limited. By employing a quad-cell detector, the sensor could respectively monitor the position of an object in two dimensions. Such alterations, modifications and improvements are
25 intended to be within the spirit and scope of the invention. Accordingly, the foregoing description is by way of example only and is not intended as limiting. The invention is limited only as defined in the following claims and the equivalents thereto.

What is claimed is:



CLAIMS

1. A device for measuring the displacement of a movable object comprising:
 - a stationary light source that produces an incident light beam;
 - 5 a target feature, attached to the object, that reflects the incident light beam and forms a first image of the light source in close proximity of the target feature;
 - an imaging lens, that receives the first image and reforms the first image as a second image of the light source on a photodetector; and
 - the photodetector, spaced from the object, that receives the second image and, in response
 - 10 thereto, produces an electric signal having a characteristic which is proportional to a received location on the photodetector of the second image and which represents a position of the object;
 - wherein the target feature is formed by ruling a groove within the object.
2. The device as claimed in claim 1 wherein target feature groove is semi-cylindrical in shape.
- 15 3. The device as claimed in claim 1 wherein the target feature has a radius of curvature within the range of 0.2 - 5.0 mm.
4. An optical position sensing device for sensing a position of a read/write head arm relative
- 20 to that of a master arm in a disk drive, the device comprising:
 - a light source, attached to the master arm, that produces an incident light beam;
 - a target feature, attached to the head arm, that reflects the incident light beam and forms a first image of the light source in close proximity of the target feature;
 - an imaging lens located in a light path between the target feature and a photodetector, that
 - 25 receives the reflected light beam, and refocuses the first image of the light source as a second image on the photodetector; and
 - the photodetector, attached to the master arm, that receives the second image and, in response thereto, produces an electric signal having a characteristic which is proportional to a

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received location on the photodetector of the second image and which represents a relative position of the head arm;

wherein the target feature is formed by ruling a groove within the head arm.

5 5. The device as claimed in claim 4 wherein the target feature groove is semi-cylindrical in shape.

6. The device as claimed in claim 4 wherein the target feature has a radius of curvature within the range of 0.2 - 5.0 mm.

10

7. A method of forming a target feature in an object, a displacement of the object to be sensed by a displacement sensor, the displacement sensor including a light source that produces an incident light beam to be reflected from the target feature and a photodetector that receives an image of the light source from the light reflected by the target feature, the method comprises the steps of:

15 bringing a ruling surface of a ruling tool into contact with a surface of object; and
 while maintaining pressure on the tool against the object surface, ruling the target feature into the surface of the object.

8. The method claimed in claim 7 wherein the step of ruling includes the step of retaining the
20 object stationary.

9. The method claimed in claim 7 wherein the step of ruling includes the step of retaining the tool stationary.